



SOCKET NO: 216648US2

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9/5/03

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF :  
HIROYOSHI TANIMOTO, ET AL. : EXAMINER: PERKINS, P. E.  
SERIAL NO: 10/001,977 :  
FILED: DECEMBER 5, 2001 : GROUP ART UNIT: 2822  
FOR: SEMICONDUCTOR DEVICE, :  
METHOD OF MANUFACTURING  
SEMICONDUCTOR DEVICE, AND  
SYSTEM FOR EVALUATING  
ELECTRICAL CHARACTERISTICS OF  
SEMICONDUCTOR DEVICE

AMENDMENT

COMMISSIONER FOR PATENTS  
ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated February 26, 2003, please amend the above-identified application as follows:

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks** begin on page 11 of this paper.

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AUG 29 2003  
TECHNOLOGY CENTER 2800